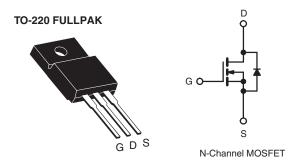


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	100				
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V 0.077				
Q _g (Max.) (nC)	72				
Q _{gs} (nC)	11				
Q _{gd} (nC)	32				
Configuration	Single				



FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz



- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION		
Package	TO-220 FULLPAK	
Lead (Pb)-free	IRFI540GPbF	
Lead (FD)-liee	SiHFI540G-E3	
SnPb	IRFI540G	
SHED	SiHFI540G	

ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, u	nless otherw	rise noted		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V_{DS}	100	V
Gate-Source Voltage			V_{GS}	± 20	v
Continuous Drain Current	V at 10 V	T _C = 25 °C	I _D	17	
Continuous Drain Current	Continuous Drain Current V_{GS} at 10 V $T_{C} = 100 ^{\circ}\text{C}$			12	Α
Pulsed Drain Current ^a			I _{DM}	68	
Linear Derating Factor				0.32	W/°C
Single Pulse Avalanche Energy ^b			E _{AS}	720	mJ
Repetitive Avalanche Current ^a			I _{AR}	17	Α
Repetitive Avalanche Energy ^a			E _{AR}	4.8	mJ
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	48	W
Peak Diode Recovery dV/dt ^c			dV/dt	5.5	V/ns
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d	
Mounting Torque	6 22 or l	M3 screw		10	lbf ⋅ in
Mounting Forque	0-32 01 1	AIO 2016M		1.1	N · m

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 3.7 mH, R_G = 25 Ω , I_{AS} = 17 A (see fig. 12). c. $I_{SD} \le 17$ A, $dI/dt \le 200$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFI540G, SiHFI540G

Vishay Siliconix



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.1	C/VV

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							•
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 250 μA	100	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	ce to 25 °C, I _D = 1 mA	-	0.13	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V	-	-	± 100	nA
Zava Cata Valtaga Dvain Cuvvant	1	V _{DS} =	= 100 V, V _{GS} = 0 V	-	-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 80 V	, V _{GS} = 0 V, T _J = 150 °C	-	-	250	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 10 A ^b	-	-	0.077	Ω
Forward Transconductance	9 _{fs}	V _{DS} :	= 50 V, I _D = 10 A ^b	9.1	-	-	S
Dynamic							•
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	1700	-	
Output Capacitance	C _{oss}]	$V_{DS} = 25 V$,	-	560	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.	.0 MHz, see fig. 5	-	120	-	pF
Drain to Sink Capacitance	С		f = 1.0 MHz		12	-	
Total Gate Charge	Qg			-	-	72	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	11	nC
Gate-Drain Charge	Q _{gd}	1	occ ng. c and ro	-	-	32	
Turn-On Delay Time	t _{d(on)}			-	11	-	
Rise Time	t _r			-	44	-	
Turn-Off Delay Time	t _{d(off)}	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$		-	ns		
Fall Time	t _f	see fig. 10 ^b		-	43	-	1
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from		-	4.5	-	
Internal Source Inductance	L _S	package and center of die contact		-	7.5	-	nH
Drain-Source Body Diode Characteristic	s						•
Continuous Source-Drain Diode Current	I _S	MOSFET sym	nbol	-	-	17	А
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	68	
Body Diode Voltage	V_{SD}	$T_{J} = 25 ^{\circ}\text{C}, I_{S} = 17 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	2.5	V
Body Diode Reverse Recovery Time	t _{rr}	T 25 °C 1	= 17 A, dl/dt = 100 A/μs ^b	_	180	360	ns
Body Diode Reverse Recovery Charge	Q _{rr}	1 J = 25 C, IF	. – 17 A, αί/αι = 100 A/μS	-	1.3	2.6	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time is negligible (turn	on is don	ninated by	y L _S and I	_D)

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

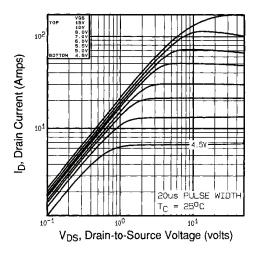


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

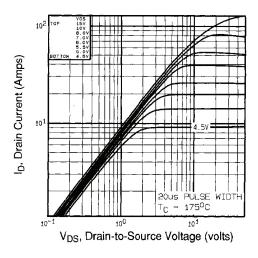


Fig. 2 - Typical Output Characteristics, $T_C = 175$ °C

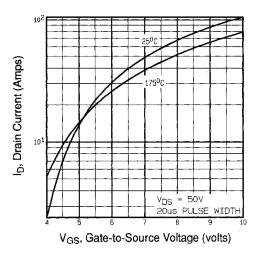


Fig. 3 - Typical Transfer Characteristics

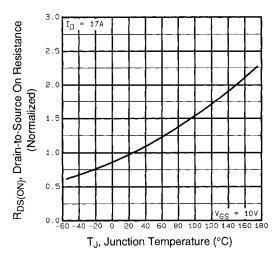


Fig. 4 - Normalized On-Resistance vs. Temperature



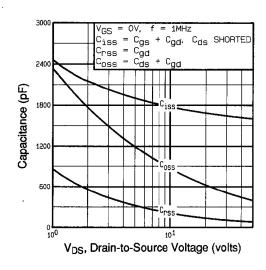


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

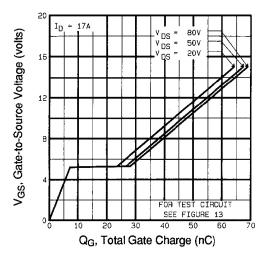


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

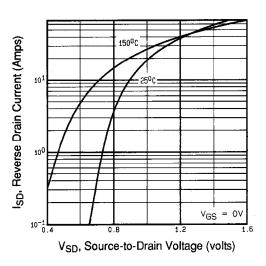


Fig. 7 - Typical Source-Drain Diode Forward Voltage

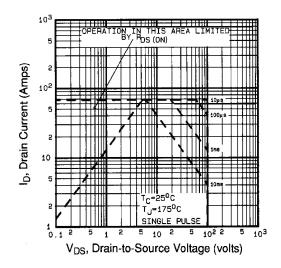


Fig. 8 - Maximum Safe Operating Area





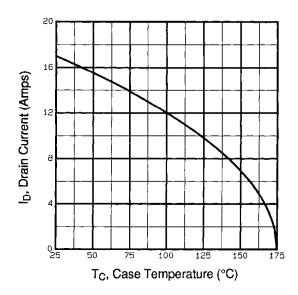


Fig. 9 - Maximum Drain Current vs. Case Temperature

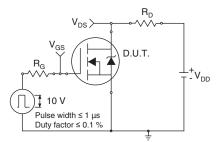


Fig. 10a - Switching Time Test Circuit

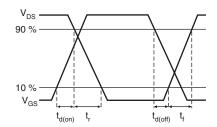


Fig. 10b - Switching Time Waveforms

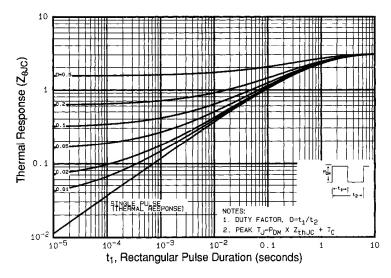


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

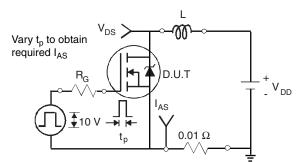


Fig. 12a - Unclamped Inductive Test Circuit

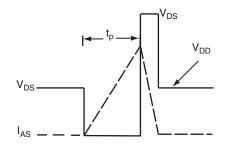


Fig. 12b - Unclamped Inductive Waveforms



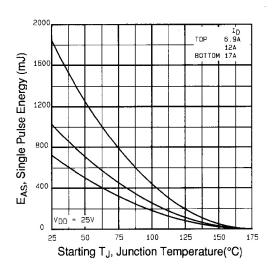


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

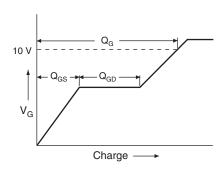


Fig. 13a - Basic Gate Charge Waveform

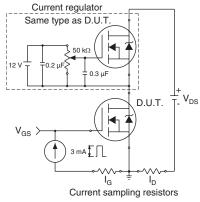
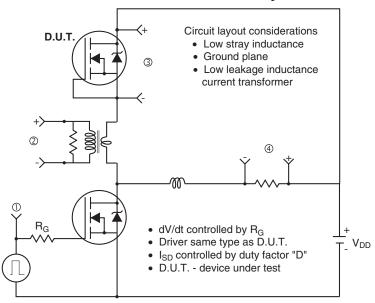
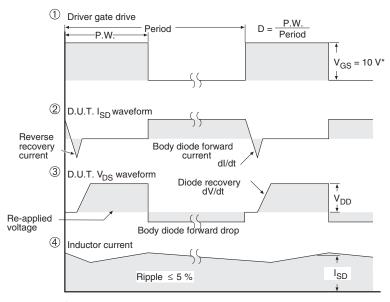


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* V_{GS} = 5 V for logic level devices

Fig.14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91144.

TO-220 FULLPAK (High Voltage)

OPTION 1: FACILITY CODE = 9



		MILLIMETERS	
DIM.	MIN.	NOM.	MAX.
Α	4.60	4.70	4.80
b	0.70	0.80	0.91
b1	1.20	1.30	1.47
b2	1.10	1.20	1.30
С	0.45	0.50	0.63
D	15.80	15.87	15.97
е		2.54 BSC	
E	10.00	10.10	10.30
F	2.44	2.54	2.64
G	6.50	6.70	6.90
L	12.90	13.10	13.30
L1	3.13	3.23	3.33
Q	2.65	2.75	2.85
Q1	3.20	3.30	3.40
ØR	3.08	3.18	3.28

Notes

- 1. To be used only for process drawing
- 2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads
- 3. All critical dimensions should C meet $C_{pk} > 1.33$
- 4. All dimensions include burrs and plating thickness
- 5. No chipping or package damage
- 6. Facility code will be the 1st character located at the 2nd row of the unit marking



OPTION 2: FACILITY CODE = Y



	MILLIMETERS		MILLIMETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.570	4.830	0.180	0.190		
A1	2.570	2.830	0.101	0.111		
A2	2.510	2.850	0.099	0.112		
b	0.622	0.890	0.024	0.035		
b2	1.229	1.400	0.048	0.055		
b3	1.229	1.400	0.048	0.055		
С	0.440	0.629	0.017	0.025		
D	8.650	9.800	0.341	0.386		
d1	15.88	16.120	0.622	0.635		
d3	12.300	12.920	0.484	0.509		
Е	10.360	10.630	0.408	0.419		
е	2.54	2.54 BSC		0.100 BSC		
L	13.200	13.730	0.520	0.541		
L1	3.100	3.500	0.122	0.138		
n	6.050	6.150	0.238	0.242		
ØΡ	3.050	3.450	0.120	0.136		
u	2.400	2.500	0.094	0.098		
V	0.400	0.500	0.016	0.020		

ECN: E19-0180-Rev. D, 08-Apr-2019

DWG: 5972

Notes

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- 2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads
- 3. All critical dimensions should C meet $C_{pk} > 1.33$
- 4. All dimensions include burrs and plating thickness
- 5. No chipping or package damage
- 6. Facility code will be the 1st character located at the 2nd row of the unit marking



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Vishay

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